Notice of References Cited Application/Control No. 10/705,913 Examiner Nicholas J. Tobergte Applicant(s)/Patent Under Reexamination YOO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*	7	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0125309	07-2004	Nam et al.	349/149
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001507481 W	06-2001	Japan	SCHURIG, D	
	0					
	Р					
	Q					
<u> </u>	R					* · ·
	s_					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	>						
	8						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.